

<b>Notice of References Cited</b>	Application/Control No. 10/539,757	Applicant(s)/Patent Under Reexamination YOSHIDA ET AL.	
	Examiner DEREK S. CHAPEL	Art Unit 2872	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,481,384	01-1996	Kramer et al.	359/17
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

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